	S	ear	cn	NC	res	;
Ш			Ш	Ш		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/606,659	WANG ET AL.	
Examiner	Art Unit	
Thomas M. Ho	2132	

	SEARCHED			
Class	Subclass	Date	Examiner	
726	22-25	11/16/2006	тн	
				
			- -	
-			,	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
EAST: USPATENT, EPO, JPO, DERWENT, USPGPUB	2/26/2007	тн
EAST: USPATENT, EPO, JPO, DERWENT, USPGPUB	4/17/2006	тн
EAST: USPATENT, EPO, JPO, DERWENT, USPGPUB	7/31/2006	ТН
EAST: USPATENT, EPO, JPO, DERWENT, USPGPUB	11/16/2006	тн
EAST: USPATENT, EPO, JPO, DERWENT, USPGPUB	2/5/2007	ТН